# Power MOSFET and **Schottky Diode**

# 20 V, 4.6 A, N-Channel, with 2.0 A Schottky Barrier Diode, 2x2 mm **WDFN Package**

### **Features**

- WDFN 2x2 mm Package Provides Exposed Drain Pad for **Excellent Thermal Conduction**
- Footprint Same as SC-88 Package
- 1.8 V V<sub>GS</sub> Rated R<sub>DS(on)</sub>
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- Low VF 2 A Schottky Diode
- This is a Pb-Free Device

#### **Applications**

- DC-DC Boost/Buck Converter
- Low Voltage Hard Disk DC Power Source

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Paramet	Parameter				Unit
Drain-to-Source Voltage			$V_{DSS}$	20	V
Gate-to-Source Voltage			$V_{GS}$	±12	V
Continuous Drain Current	Steady	T <sub>A</sub> = 25°C	$I_{D}$	3.8	Α
(Note 1)	State	T <sub>A</sub> = 85°C		2.8	1
	t ≤ 5 s	T <sub>A</sub> = 25°C		4.6	1
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.5	W
	t ≤ 5 s			2.2	1
Continuous Drain Current		T <sub>A</sub> = 25°C	I <sub>D</sub>	2.6	Α
(Note 2)	Steady	T <sub>A</sub> = 85°C		1.9	
Power Dissipation (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.7	
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	18	Α
Operating Junction and Stor	T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C		
Source Current (Body Diode	I <sub>S</sub>	1.8	Α		
Lead Temperature for Solde (1/8" from case for 10 s)	TL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be

- assumed, damage may occur and reliability may be affected.

  1. Surface Mounted on FR4 Board using 2 in sq pad size
- (Cu area = 1.127 in sq [2 oz] including traces).

  2. Surface Mounted on FR4 Board using the minimum recommended pad size.



# ON Semiconductor®

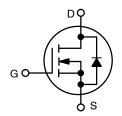
#### www.onsemi.com

#### **MOSFET**

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max
	65 mΩ @ 4.5 V	3.8 A
20 V	85 mΩ @ 2.5 V	2.0 A
	120 mΩ @ 1.8 V	1.7 A

### **SCHOTTKY DIODE**

V <sub>R</sub> Max	V <sub>F</sub> Typ	I <sub>F</sub> Max
20 V	0.41 V	2.0 A





**N-CHANNEL MOSFET** 

**SCHOTTKY DIODE** 



**CASE 506AN** 

JK



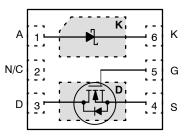
**MARKING** 

= Specific Device Code

= Date Code Μ = Pb-Free Package

(Note: Microdot may be in either location)

#### PIN CONNECTIONS



(Top View)

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 3 of

# SCHOTTKY DIODE MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Peak Repetitive Reverse Voltage	$V_{RRM}$	20	V
DC Blocking Voltage	V <sub>R</sub>	20	V
Average Rectified Forward Current	I <sub>F</sub>	2.0	Α

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	83	
Junction-to-Ambient – $t \le 5$ s (Note 3)	$R_{ heta JA}$	58	°C/W
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ heta JA}$	177	

<sup>3.</sup> Surface Mounted on FR4 Board using 2 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).

# $\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS			-	_		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA, Ref to 25°C		10.4		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$ $T_{J} = 25^{\circ}$ $T_{.1} = 85^{\circ}$			1.0 10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8.0 \text{ V}$			±100	nA
ON CHARACTERISTICS (Note 5)					-	-
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	0.4	0.7	1.0	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>			-3.0		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5, I <sub>D</sub> = 3.8 A		37	65	mΩ
		V <sub>GS</sub> = 2.5, I <sub>D</sub> = 2.0 A		46	85	
		V <sub>GS</sub> = 1.8, I <sub>D</sub> = 1.7 A		65	120	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> =1.7 A		4.2		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	CE				
Input Capacitance	C <sub>ISS</sub>			271		pF
Output Capacitance	Coss	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz, } V_{DS} = 10 \text{ V}$		72		
Reverse Transfer Capacitance	C <sub>RSS</sub>			43		
Total Gate Charge	Q <sub>G(TOT)</sub>			3.7		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V, I <sub>D</sub> = 3.8 A		0.3		
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}, I_{D} = 3.8 \text{ F}$	`	0.6		
Gate-to-Drain Charge	$Q_{GD}$			1.0		
SWITCHING CHARACTERISTICS (No	ote 6)					
Turn-On Delay Time	t <sub>d(ON)</sub>			3.8		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DD</sub> = 16 V,		4.7		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DD} = 16 \text{ V},$ $I_D = 1.0 \text{ A}, R_G = 2.0 \Omega$		11.1		
Fall Time	t <sub>f</sub>			5.8		
DRAIN-SOURCE DIODE CHARACTE	RISTICS					
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V, IS =1.0 A T <sub>J</sub> = 25°	°C	0.69	1.0	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V}, d_{ISD}/d_t = 100 \text{ A/}\mu\text{s}, I_S = 1.00 \text{ A/}\mu\text{s}$	0 A	10.2		ns
		-		-		-

<sup>5.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

<sup>4.</sup> Surface Mounted on FR4 Board using the minimum recommended pad size.

<sup>6.</sup> Switching characteristics are independent of operating junction temperatures.

# SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 0.1 A		0.26	0.35	V
Forward Voltage		I <sub>F</sub> = 1.0 A		0.35	0.42	
		I <sub>F</sub> = 2.0 A		0.41	0.52	
Maximum Instantaneous Reverse Current	I <sub>R</sub>	V <sub>R</sub> = 20 V		0.20	5.0	mA
		V <sub>R</sub> = 10 V		0.045	1.0	1

# SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 85°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 0.1 A		0.18		V
Forward Voltage		I <sub>F</sub> = 1.0 A		0.29		
		I <sub>F</sub> = 2.0 A		0.36		
Maximum Instantaneous	I <sub>R</sub>	V <sub>R</sub> = 20 V		4.9		mA
Reverse Current		V <sub>R</sub> = 10 V		1.6		1

# SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS ( $T_J = 125^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Maximum Instantaneous	V <sub>F</sub>	I <sub>F</sub> = 0.1 A		0.13		V
Forward Voltage		I <sub>F</sub> = 1.0 A		0.25		
		I <sub>F</sub> = 2.0 A		0.33		
Maximum Instantaneous Reverse Current	I <sub>R</sub>	V <sub>R</sub> = 20 V		42		mA
		V <sub>R</sub> = 10 V		13		

# SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Capacitance	С	$V_R = 5.0 \text{ V, f} = 1.0 \text{ MHz}$		52.3		pF

# **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLJF3118NTAG	WDFN6 (Pb-Free)	3000 / Tape & Reel
NTLJF3118NTBG	WDFN6 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# TYPICAL N-CHANNEL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

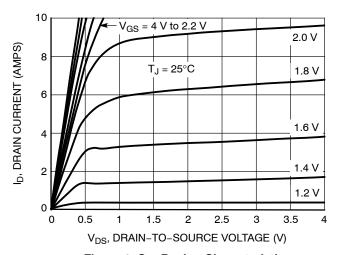


Figure 1. On-Region Characteristics

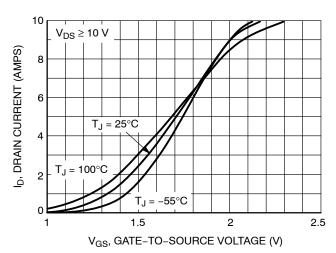


Figure 2. Transfer Characteristics

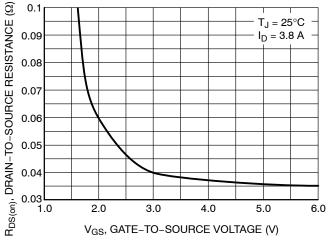


Figure 3. On-Resistance versus Drain Current

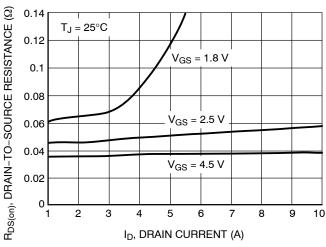


Figure 4. On-Resistance versus Drain Current and Gate Voltage

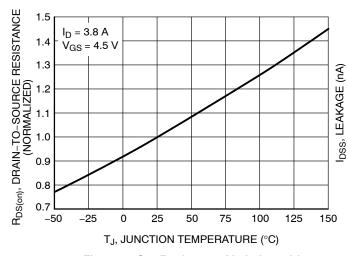


Figure 5. On–Resistance Variation with Temperature

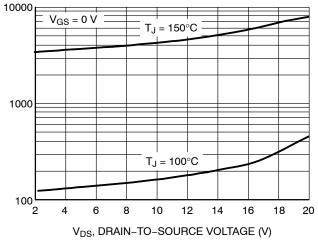
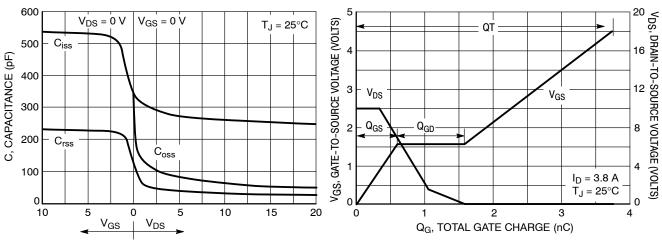


Figure 6. Drain-to-Source Leakage Current versus Voltage

# TYPICAL N-CHANNEL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

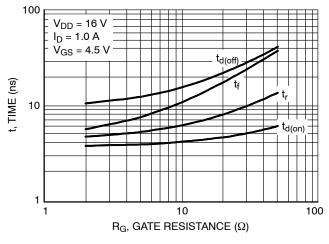


Figure 9. Resistive Switching Time Variation versus Gate Resistance

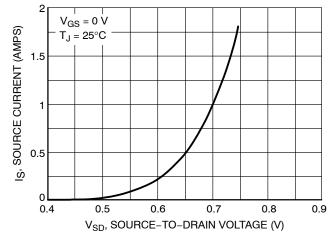
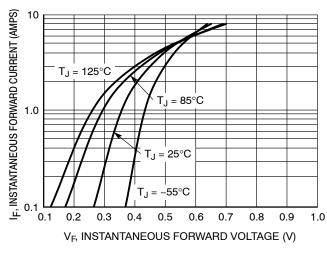


Figure 10. Diode Forward Voltage versus Current

# TYPICAL SCHOTTKY PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



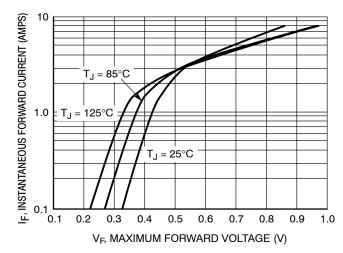


Figure 11. Typical Forward Voltage

Figure 12. Maximum Forward Voltage

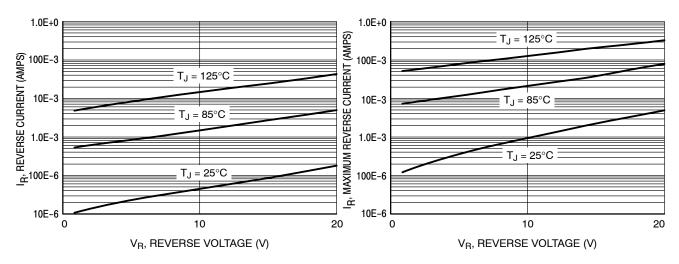
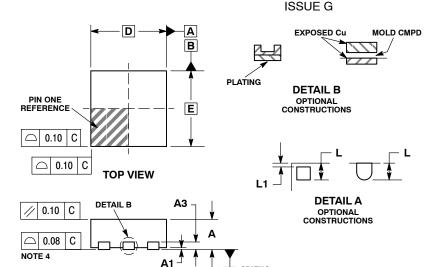


Figure 13. Typical Reverse Current

Figure 14. Maximum Reverse Current

#### PACKAGE DIMENSIONS

# **WDFN6 2x2, 0.65P** CASE 506AN



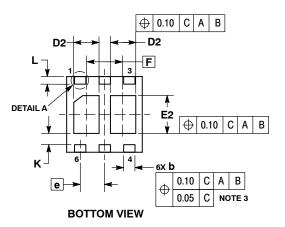
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#### NOTES:

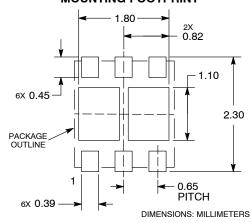
- DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M. 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- 3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN
- 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
  4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIM	ETERS	
DIM	MIN	MAX	
Α	0.70	0.80	
A1	0.00	0.05	
A3	0.20	REF	
b	0.25	0.35	
D	2.00 BSC		
D2	0.57	0.77	
E	2.00	BSC	
E2	0.90	1.10	
е	0.65	BSC	
F	0.95 BSC		
K	0.25 REF		
L	0.20	0.30	
L1		0.10	

# SOLDERMASK DEFINED MOUNTING FOOTPRINT



**SIDE VIEW** 



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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